

C3M0120065J

Silicon Carbide Power MOSFET

C3M™ MOSFET Technology

N-Channel Enhancement Mode

Features

- 3rd Generation SiC MOSFET technology
- Low inductance package with driver source pin
- 7mm of creepage distance between drain and source
- High blocking voltage with low on-resistance
- High speed switching with low capacitances
- Fast intrinsic diode with low reverse recovery (Qrr)
- Halogen free, RoHS compliant

Benefits

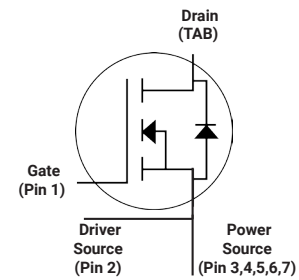
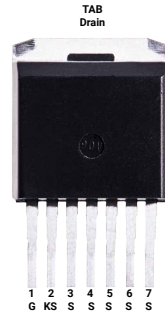
- Higher system efficiency
- Reduced cooling requirements
- Increased power density
- Increased system switching frequency
- Easy to parallel and simple to drive
- Enable new hard switching PFC topologies (Totem-Pole)

Applications

- Solar inverters
- DC/DC converters
- Switch Mode Power Supplies
- EV battery chargers
- UPS

| | |
|--------------------------|--------|
| V_{DS} | 650 V |
| $I_D @ 25^\circ\text{C}$ | 21 A |
| $R_{DS(on)}$ | 120 mΩ |

Package



| Part Number | Package | Marking |
|-------------|----------|-------------|
| C3M0120065J | TO-263-7 | C3M0120065J |

Maximum Ratings

| Symbol | Parameter | Value | Unit | Note |
|----------------|------------------------------------------------------------------------------|-------------|------------------|---------|
| V_{DSS} | Drain - Source Voltage, $T_c = 25^\circ\text{C}$ | 650 | V | |
| V_{GS} | Gate - Source voltage (Under transient events < 100 ns) | -8/+19 | V | Fig. 28 |
| I_D | Continuous Drain Current, $V_{GS} = 15\text{ V}$, $T_c = 25^\circ\text{C}$ | 21 | A | Fig. 19 |
| | Continuous Drain Current, $V_{GS} = 15\text{ V}$, $T_c = 100^\circ\text{C}$ | 15 | | |
| $I_{D(pulse)}$ | Pulsed Drain Current, Pulse width t_p limited by T_{jmax} | 51 | A | |
| P_D | Power Dissipation, $T_c = 25^\circ\text{C}$, $T_j = 175^\circ\text{C}$ | 86 | W | Fig. 20 |
| T_j, T_{stg} | Operating Junction and Storage Temperature | -40 to +175 | $^\circ\text{C}$ | |
| T_L | Solder Temperature, 1.6mm (0.063") from case for 10s | 260 | $^\circ\text{C}$ | |

| Symbol | Parameter | Min. | Typ. | Max. | Unit | Test Conditions | Note |
|---------------|-----------------------------------------------|------|------|------|---------------|------------------------------------------------------------------------------------------------------------------------------------------------------------------|--------------|
| $V_{(BR)DSS}$ | Drain-Source Breakdown Voltage | 650 | | | V | $V_{GS} = 0\text{ V}, I_D = 100\ \mu\text{A}$ | |
| V_{GSon} | Gate-Source Recommended Turn-On Voltage | | 15 | | V | Static | Fig. 29 |
| V_{GSoff} | Gate-Source Recommended Turn-Off Voltage | | -4 | | V | | |
| $V_{GS(th)}$ | Gate Threshold Voltage | 1.8 | 2.3 | 3.6 | V | $V_{DS} = V_{GS}, I_D = 1.86\ \text{mA}$ | Fig. 11 |
| | | | 1.9 | | V | $V_{DS} = V_{GS}, I_D = 1.86\ \text{mA}, T_J = 175^\circ\text{C}$ | |
| I_{DSS} | Zero Gate Voltage Drain Current | | 1 | 50 | μA | $V_{DS} = 650\ \text{V}, V_{GS} = 0\ \text{V}$ | |
| I_{GSS} | Gate-Source Leakage Current | | 10 | 250 | nA | $V_{GS} = 15\ \text{V}, V_{DS} = 0\ \text{V}$ | |
| $R_{DS(on)}$ | Drain-Source On-State Resistance | | 120 | 157 | m Ω | $V_{GS} = 15\ \text{V}, I_D = 6.76\ \text{A}$ | Fig. 4, 5, 6 |
| | | | 168 | | | $V_{GS} = 15\ \text{V}, I_D = 6.76\ \text{A}, T_J = 175^\circ\text{C}$ | |
| g_{fs} | Transconductance | | 5.0 | | S | $V_{DS} = 20\ \text{V}, I_{DS} = 6.76\ \text{A}$ | Fig. 7 |
| | | | 4.9 | | | $V_{DS} = 20\ \text{V}, I_{DS} = 6.76\ \text{A}, T_J = 175^\circ\text{C}$ | |
| C_{iss} | Input Capacitance | | 640 | | pF | $V_{GS} = 0\ \text{V}, V_{DS} = 0\ \text{V to } 400\ \text{V}$ | Fig. 17, 18 |
| C_{oss} | Output Capacitance | | 45 | | | $F = 1\ \text{MHz}$ | |
| C_{rss} | Reverse Transfer Capacitance | | 2.3 | | | $V_{AC} = 25\ \text{mV}$ | |
| $C_{o(er)}$ | Effective Output Capacitance (Energy Related) | | 57 | | | $V_{GS} = 0\ \text{V}, V_{DS} = 0\ \text{V to } 400\ \text{V}$ | Note: 1 |
| $C_{o(tr)}$ | Effective Output Capacitance (Time Related) | | 79 | | | | Note: 1 |
| E_{oss} | C_{oss} Stored Energy | | 4.3 | | μJ | $V_{DS} = 400\ \text{V}, F = 1\ \text{MHz}$ | Fig. 16 |
| E_{ON} | Turn-On Switching Energy (Body Diode) | | 28 | | μJ | $V_{DS} = 400\ \text{V}, V_{GS} = -4\ \text{V}/15\ \text{V}, I_D = 6.76\ \text{A}, R_{G(ext)} = 10\ \Omega, L = 237\ \mu\text{H}, T_J = 175^\circ\text{C}$ | Fig. 25 |
| E_{OFF} | Turn Off Switching Energy (Body Diode) | | 6 | | | FWD = Internal Body Diode of MOSFET | |
| $t_{d(on)}$ | Turn-On Delay Time | | 8 | | ns | $V_{DD} = 400\ \text{V}, V_{GS} = -4\ \text{V}/15\ \text{V}$ $I_D = 6.76\ \text{A}, R_{G(ext)} = 10\ \Omega$ Timing relative to V_{DS} Inductive load | Fig. 26 |
| t_r | Rise Time | | 9 | | | | |
| $t_{d(off)}$ | Turn-Off Delay Time | | 18 | | | | |
| t_f | Fall Time | | 9 | | | | |
| $R_{G(int)}$ | Internal Gate Resistance | | 6 | | Ω | $f = 1\ \text{MHz}, V_{AC} = 25\ \text{mV}$ | |
| Q_{gs} | Gate to Source Charge | | 8 | | nC | $V_{DS} = 400\ \text{V}, V_{GS} = -4\ \text{V}/15\ \text{V}$ $I_D = 6.76\ \text{A}$ Per IEC60747-8-4 pg 21 | Fig. 12 |
| Q_{gd} | Gate to Drain Charge | | 7 | | | | |
| Q_g | Total Gate Charge | | 26 | | | | |

Note (1): $C_{o(er)}$, a lumped capacitance that gives same stored energy as C_{oss} while V_{ds} is rising from 0 to 400V

$C_{o(tr)}$, a lumped capacitance that gives same charging time as C_{oss} while V_{ds} is rising from 0 to 400V

Reverse Diode Characteristics ($T_c = 25^\circ\text{C}$ unless otherwise specified)

| Symbol | Parameter | Typ. | Max. | Unit | Test Conditions | Note |
|----------------|----------------------------------|------|------|------|--------------------------------------------------------------------------------------------------------------------------------------|---------------|
| V_{SD} | Diode Forward Voltage | 4.5 | | V | $V_{GS} = -4\text{ V}, I_{SD} = 3.4\text{ A}, T_J = 25^\circ\text{C}$ | Fig. 8, 9, 10 |
| | | 4.0 | | V | $V_{GS} = -4\text{ V}, I_{SD} = 3.4\text{ A}, T_J = 175^\circ\text{C}$ | |
| I_S | Continuous Diode Forward Current | | 15 | A | $V_{GS} = -4\text{ V}, T_c = 25^\circ\text{C}$ | |
| $I_{S, pulse}$ | Diode pulse Current | | 51 | A | $V_{GS} = -4\text{ V}$, pulse width t_p limited by T_{jmax} | |
| t_{rr} | Reverse Recover time | 8 | | ns | $V_{GS} = -4\text{ V}, I_{SD} = 6.76\text{ A}, V_R = 400\text{ V}$ $diff/dt = 5470\text{ A}/\mu\text{s}, T_J = 175^\circ\text{C}$ | |
| Q_{rr} | Reverse Recovery Charge | 78 | | nC | | |
| I_{rrm} | Peak Reverse Recovery Current | 16 | | A | | |
| t_{rr} | Reverse Recover time | 9 | | ns | $V_{GS} = -4\text{ V}, I_{SD} = 6.76\text{ A}, V_R = 400\text{ V}$ $diff/dt = 3650\text{ A}/\mu\text{s}, T_J = 175^\circ\text{C}$ | |
| Q_{rr} | Reverse Recovery Charge | 41 | | nC | | |
| I_{rrm} | Peak Reverse Recovery Current | 7 | | A | | |

Thermal Characteristics

| Symbol | Parameter | Typ. | Unit | Test Conditions | Note |
|-----------------|---------------------------------------------|------|---------------------------|-----------------|---------|
| $R_{\theta JC}$ | Thermal Resistance from Junction to Case | 1.73 | $^\circ\text{C}/\text{W}$ | | Fig. 21 |
| $R_{\theta JA}$ | Thermal Resistance From Junction to Ambient | 40 | | | |

Typical Performance

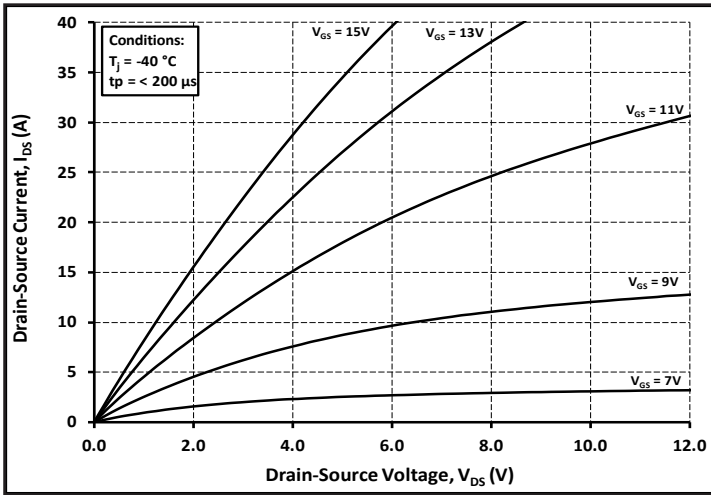


Figure 1. Output Characteristics $T_J = -40\text{ }^\circ\text{C}$

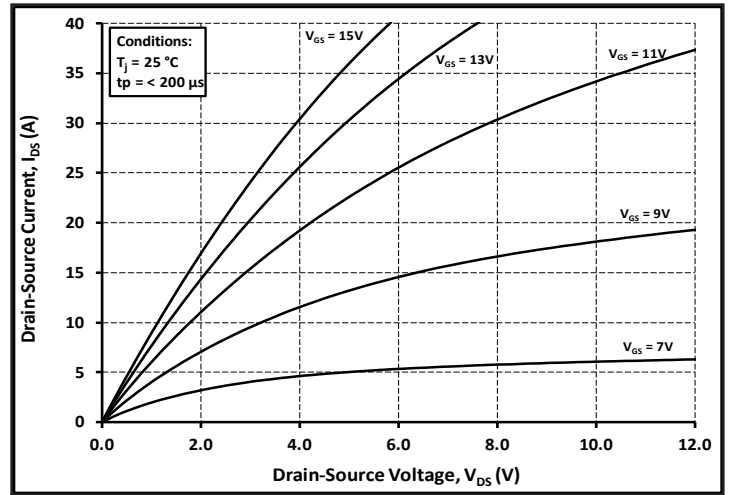


Figure 2. Output Characteristics $T_J = 25\text{ }^\circ\text{C}$

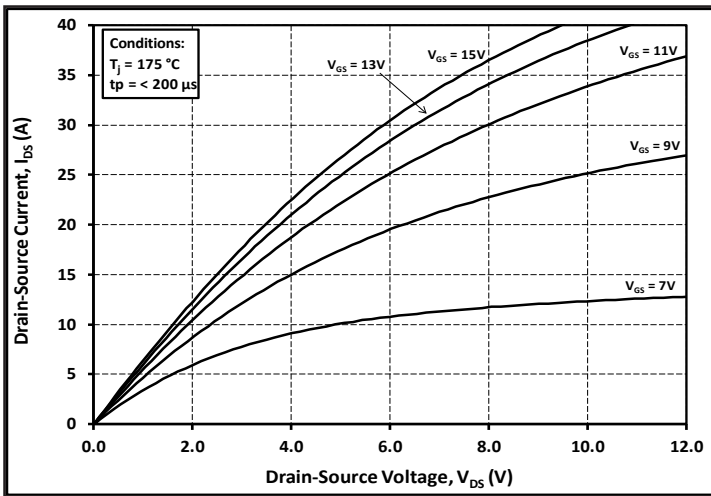


Figure 3. Output Characteristics $T_J = 175\text{ }^\circ\text{C}$

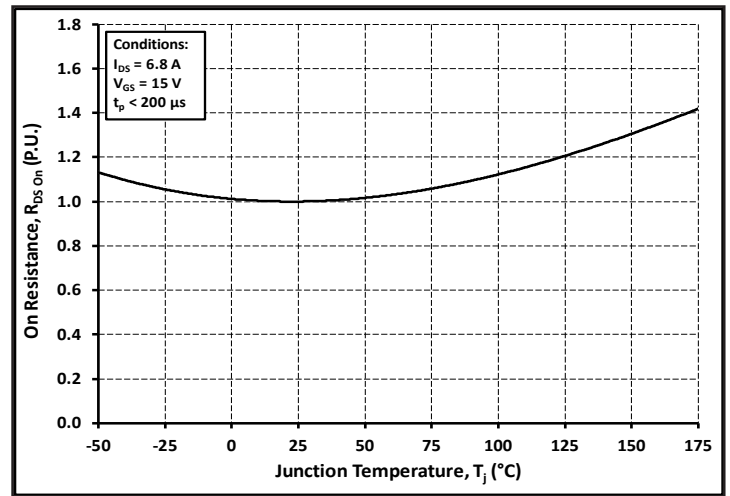


Figure 4. Normalized On-Resistance vs. Temperature

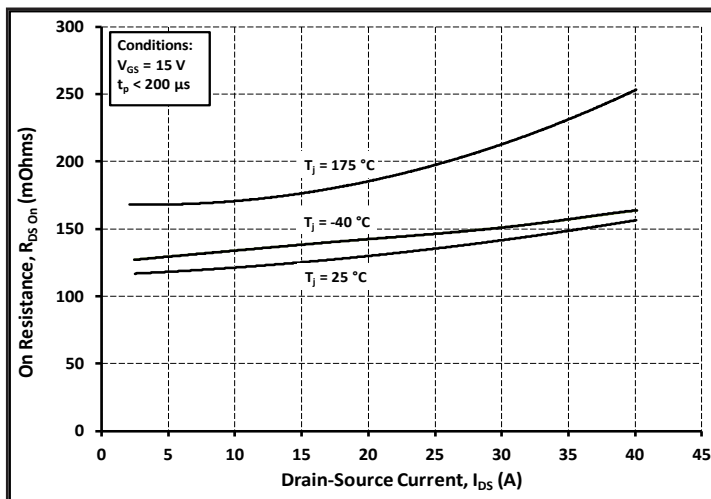


Figure 5. On-Resistance vs. Drain Current For Various Temperatures

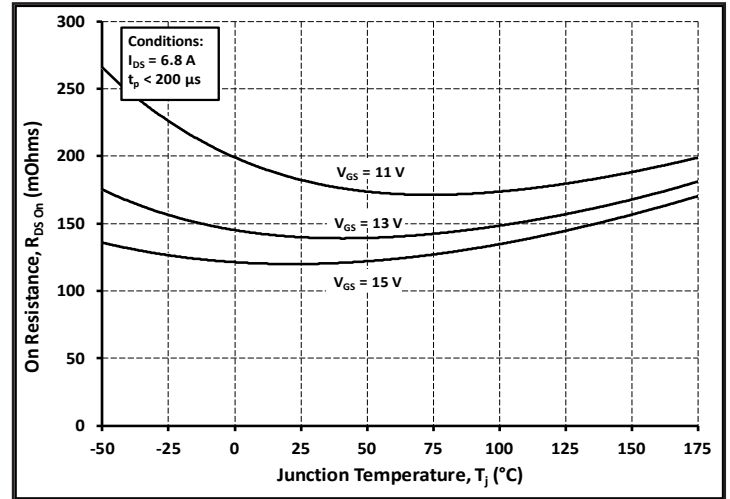


Figure 6. On-Resistance vs. Temperature For Various Gate Voltage

Typical Performance

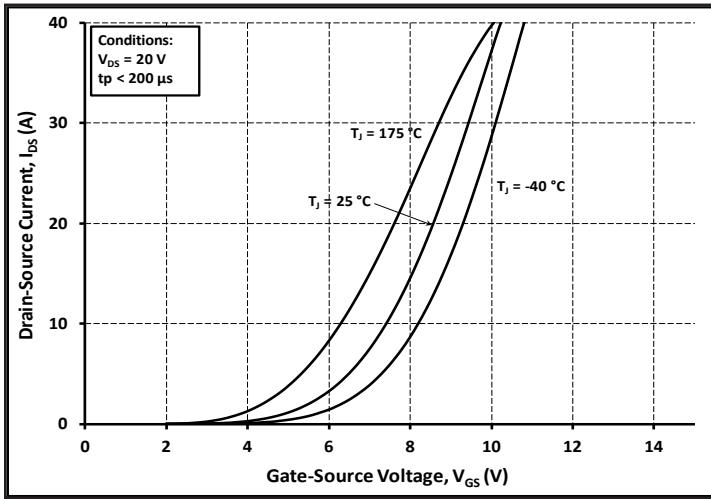


Figure 7. Transfer Characteristic for Various Junction Temperatures

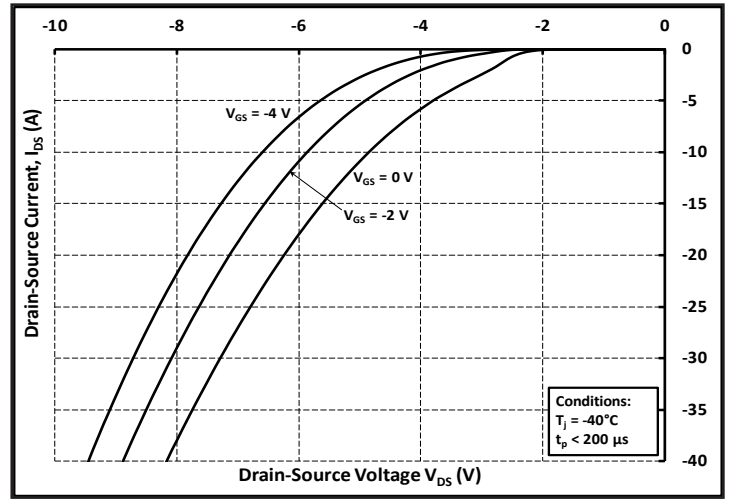


Figure 8. Body Diode Characteristic at $-40\text{ }^\circ\text{C}$

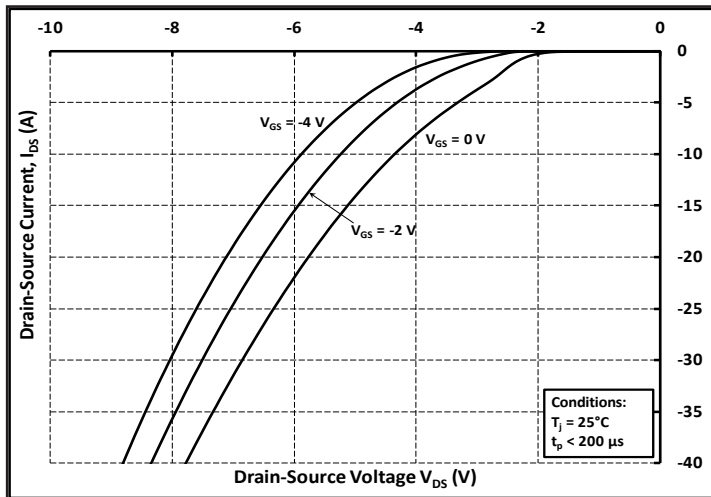


Figure 9. Body Diode Characteristic at $25\text{ }^\circ\text{C}$

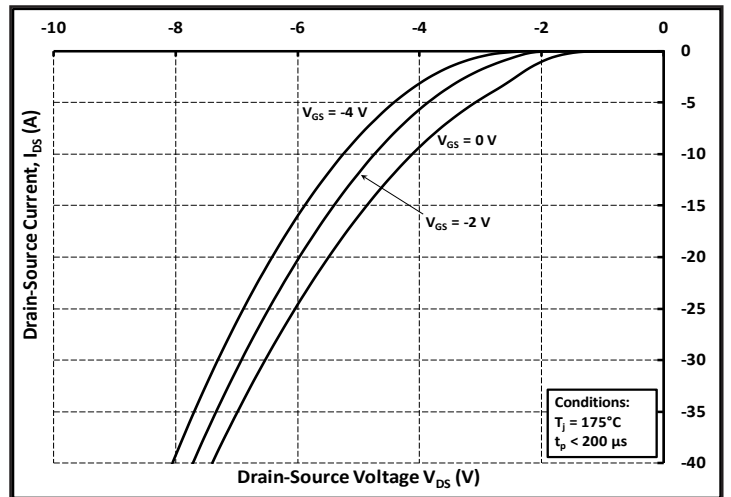


Figure 10. Body Diode Characteristic at $175\text{ }^\circ\text{C}$

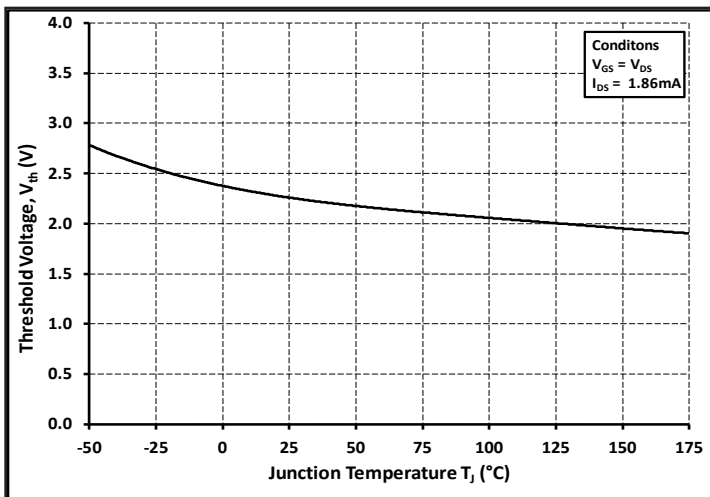


Figure 11. Threshold Voltage vs. Temperature

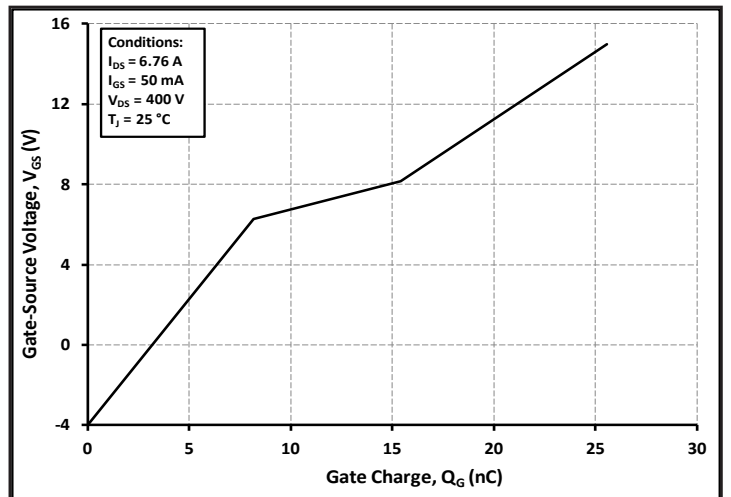


Figure 12. Gate Charge Characteristics

Typical Performance

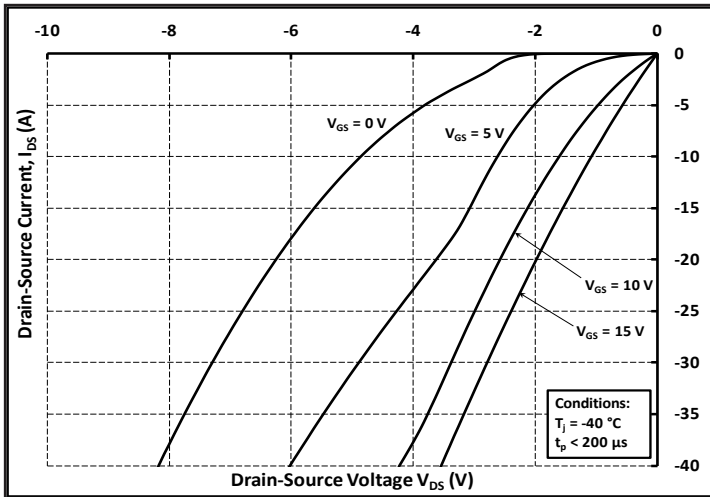


Figure 13. 3rd Quadrant Characteristic at $-40\text{ }^\circ\text{C}$

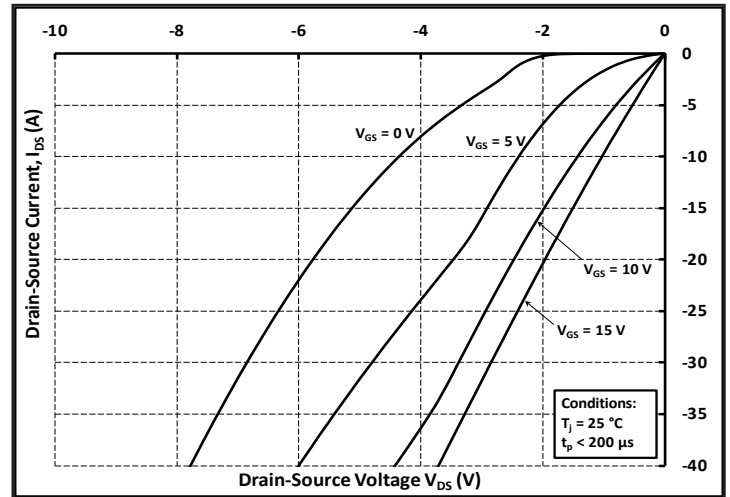


Figure 14. 3rd Quadrant Characteristic at $25\text{ }^\circ\text{C}$

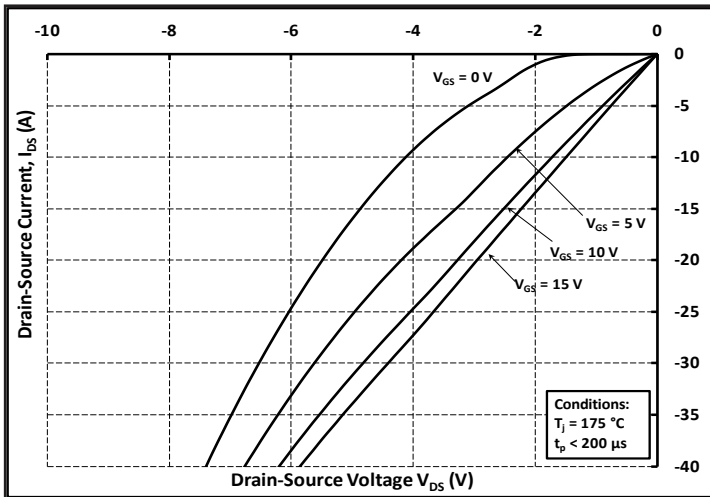


Figure 15. 3rd Quadrant Characteristic at $175\text{ }^\circ\text{C}$

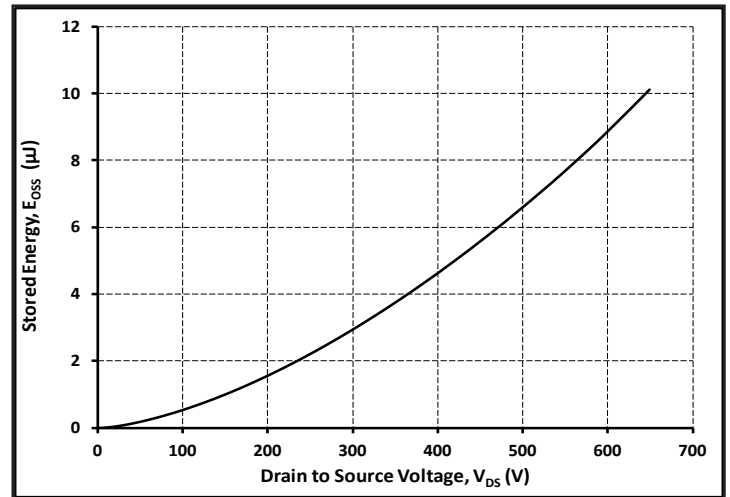


Figure 16. Output Capacitor Stored Energy

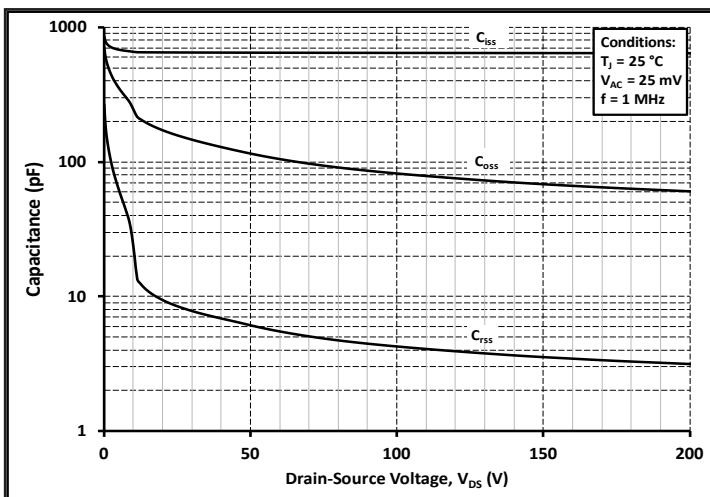


Figure 17. Capacitances vs. Drain-Source Voltage (0 - 200V)

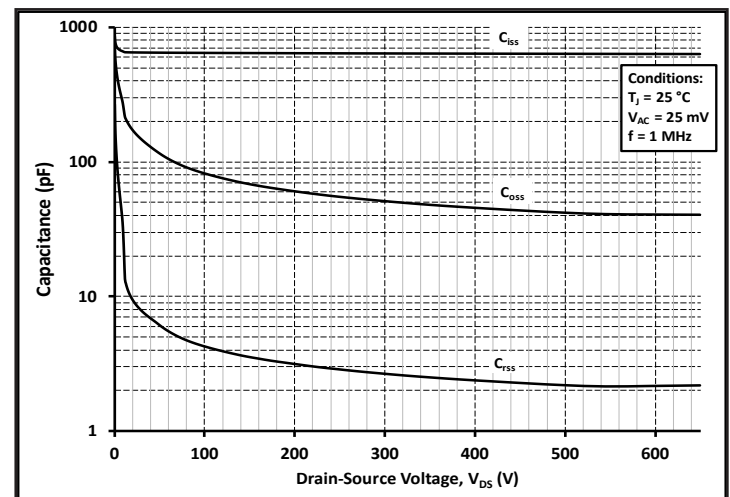


Figure 18. Capacitances vs. Drain-Source Voltage (0 - 650V)

Typical Performance

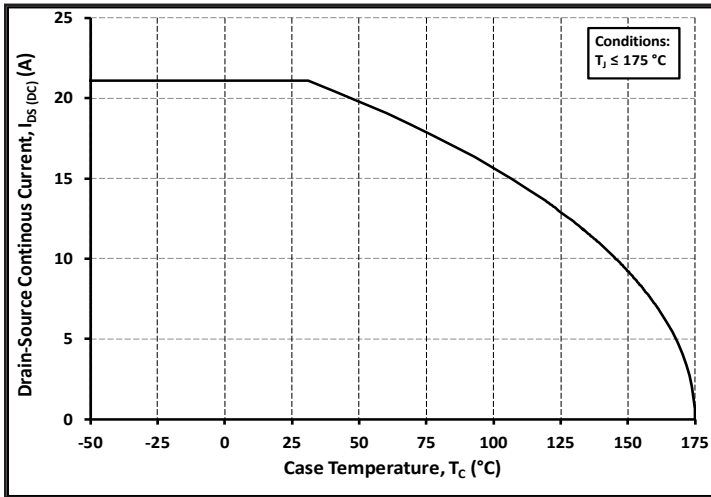


Figure 19. Continuous Drain Current Derating vs. Case Temperature

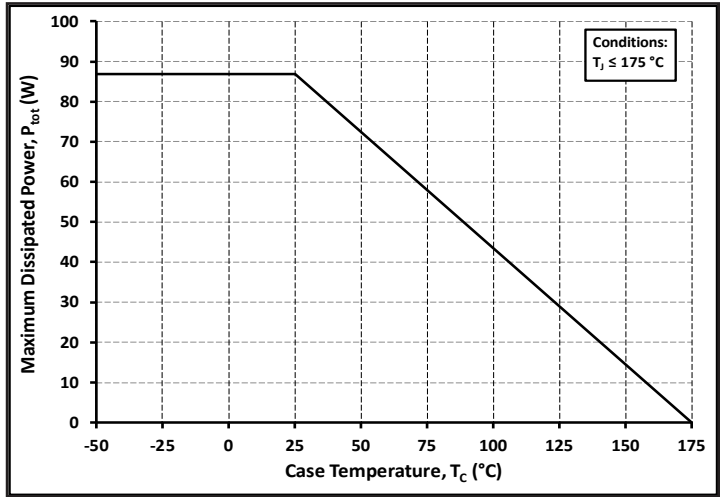


Figure 20. Maximum Power Dissipation Derating vs. Case Temperature

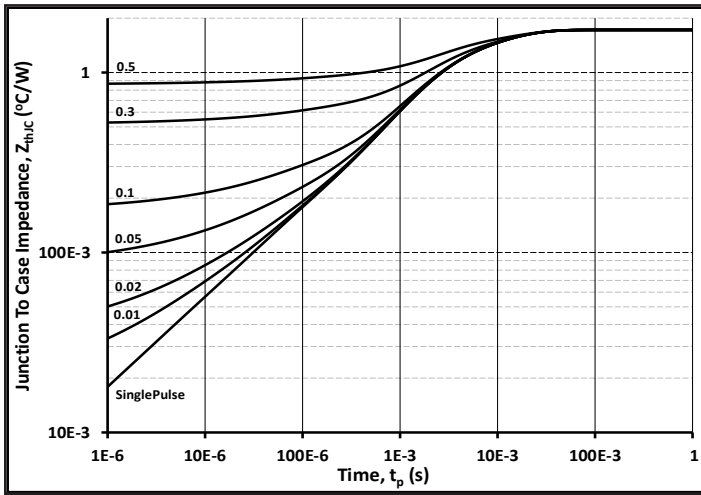


Figure 21. Transient Thermal Impedance (Junction - Case)

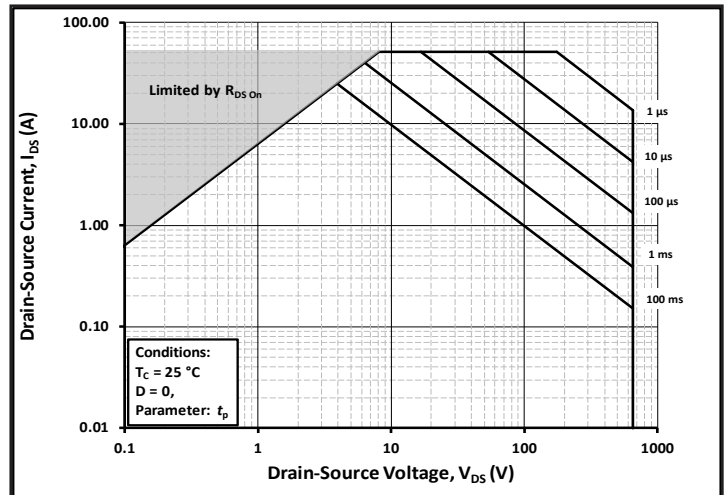


Figure 22. Safe Operating Area

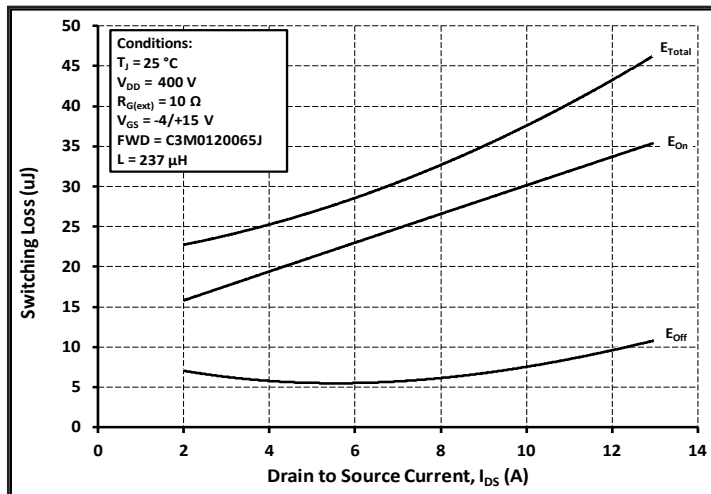


Figure 23. Clamped Inductive Switching Energy vs. Drain Current ($V_{DD} = 400V$)

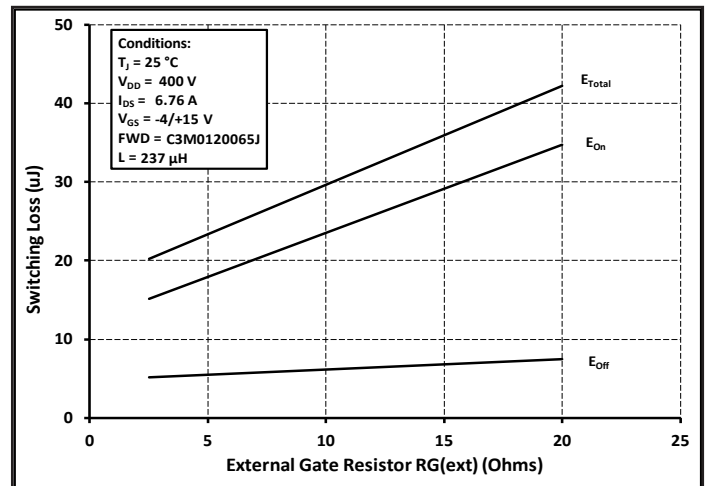


Figure 24. Clamped Inductive Switching Energy vs. $R_{G(ext)}$

Typical Performance

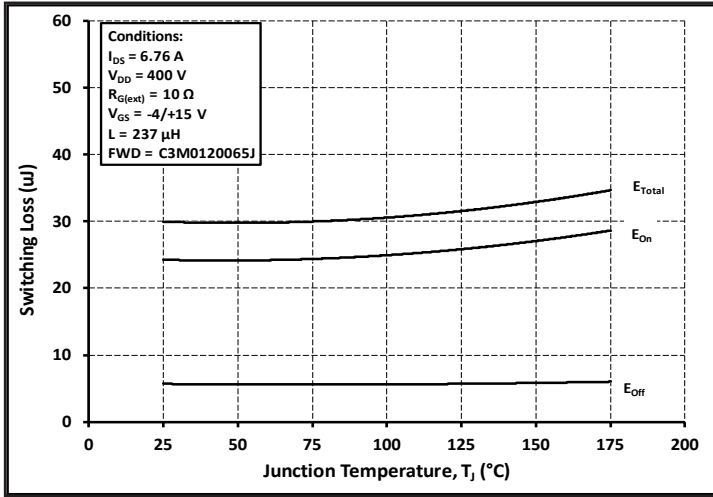


Figure 25. Clamped Inductive Switching Energy vs. Temperature

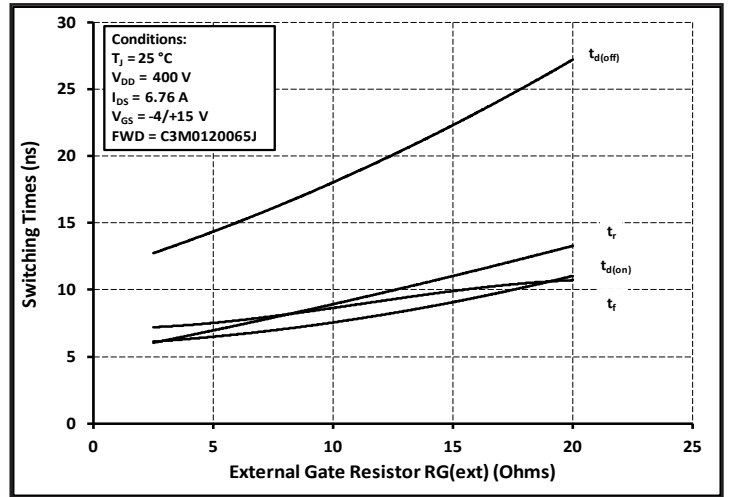


Figure 26. Switching Times vs. $R_{G(ext)}$

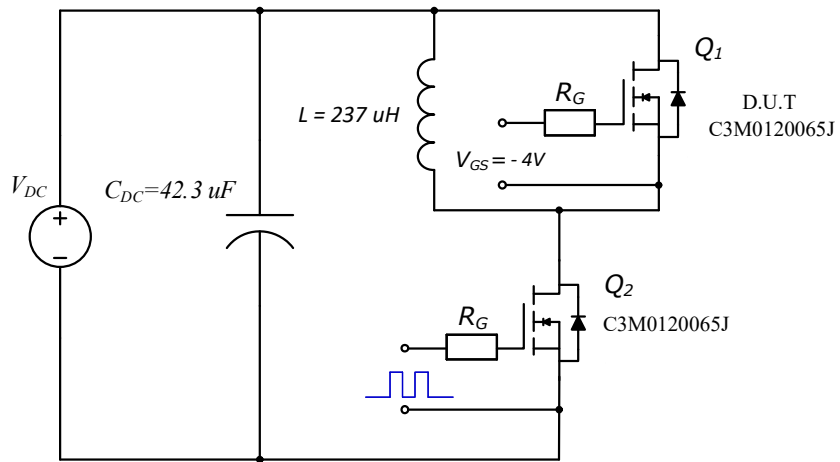


Figure 27. Clamped Inductive Switching Waveform Test Circuit

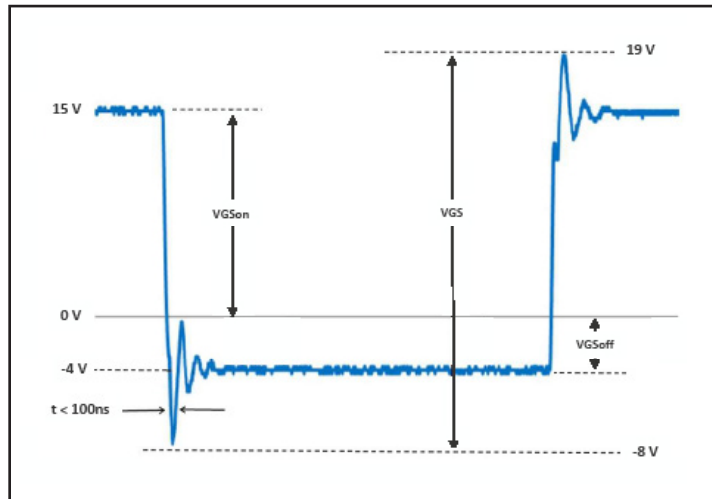
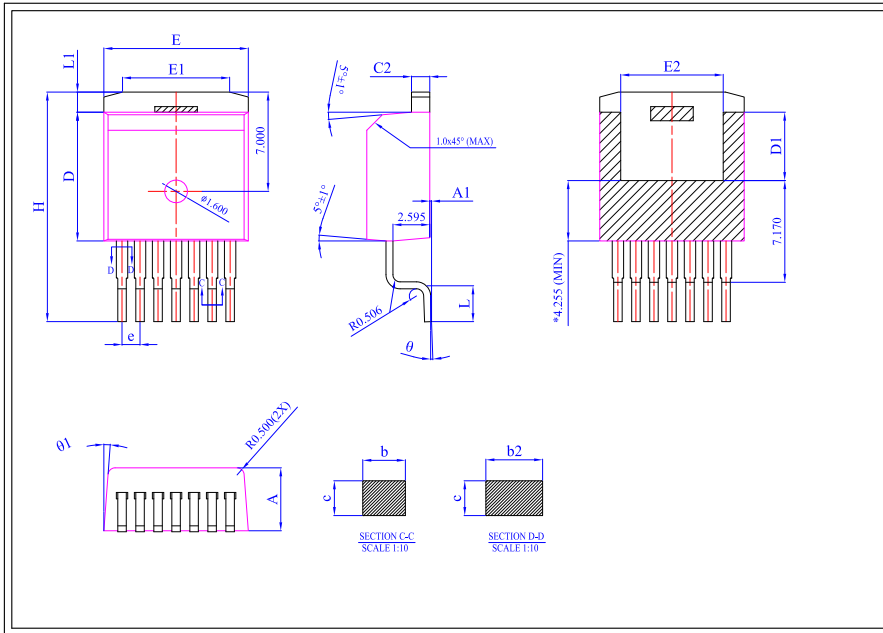


Figure 28. V_{GS} Waveform Example

Package Dimensions

Package 7L D2PAK



| Dim | All Dimensions in Millimeters | | |
|----------|-------------------------------|--------|--------|
| | Min | typ | Max |
| A | 4.300 | 4.435 | 4.570 |
| A1 | 0.00 | 0.125 | 0.25 |
| b | 0.500 | 0.600 | 0.700 |
| b2 | 0.600 | 0.800 | 1.000 |
| c | 0.330 | 0.490 | 0.650 |
| C2 | 1.170 | 1.285 | 1.400 |
| D | 9.025 | 9.075 | 9.125 |
| D1 | 4.700 | 4.800 | 4.900 |
| E | 10.130 | 10.180 | 10.230 |
| E1 | 6.500 | 7.550 | 8.600 |
| E2 | 6.778 | 7.223 | 7.665 |
| e | 1.27 | | |
| H | 15.043 | 16.178 | 17.313 |
| L | 2.324 | 2.512 | 2.700 |
| L1 | 0.968 | 1.418 | 1.868 |
| θ | 0° | 4° | 8° |
| $\phi 1$ | 4.5° | 5° | 5.5° |

